## 24小时加急出货 SEMICONDUCTORS

握多邦,专业PCB打样工厂

## **ZXTP19100CZ** 100V PNP medium power transistor in SOT89

#### Summary

BV<sub>CEO</sub> > -100V

 $BV_{ECO} > -7V$ 

 $I_{C(cont)} = 2A$ 

V<sub>CE(sat)</sub> < -130mV @ -1A

 $R_{CE(sat)} = 100m\Omega$ 

 $P_{D} = 2.4W$ 

Complementary part number ZXTN19100CZ

#### Description

Packaged in the SOT89 outline this new low saturation 100V PNP transistor offers extremely low on state losses making it ideal for use in DC-DC circuits and various driving and power management functions

#### Features

- High gain
- Low saturation voltage
- High peak current

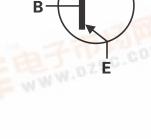
- High side driver
  Motoria
- Motor drive
- Load disconnect switch

#### **Ordering information**

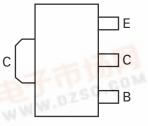
Device	Reel size	Tape width	Quantity
	(inches)	(mm)	per reel
ZXTP19100CZTA	7	0 12	1000

# Device marking

1M3



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Pinout - top view



#### Absolute maximum ratings

Parameter	Symbol	Limit	Unit
Collector-Base voltage	V <sub>CBO</sub>	-110	V
Collector-Emitter voltage (forward blocking)	V <sub>CEX</sub>	-110	V
Collector-Emitter voltage	V <sub>CEO</sub>	-100	V
Emitter-Collector voltage (reverse blocking)	V <sub>ECO</sub>	-7	V
Emitter-Base voltage	V <sub>EBO</sub>	-7	V
Continuous Collector current <sup>(c)</sup>	Ι <sub>C</sub>	-2	А
Base current	I <sub>B</sub>	-1	А
Peak pulse current	I <sub>СМ</sub>	-3	А
Power dissipation at $T_A = 25^{\circ}C^{(a)}$	PD	1.1	W
Linear derating factor		8.8	mW/°C
Power dissipation at $T_A = 25^{\circ}C^{(b)}$	PD	1.8	W
Linear derating factor		14.4	mW/°C
Power dissipation at $T_A = 25^{\circ}C^{(c)}$	PD	2.4	W
Linear derating factor		19.2	mW/°C
Power dissipation at $T_A = 25^{\circ}C^{(d)}$	PD	4.46	W
Linear derating factor		35.7	mW/°C
Power dissipation at $T_{C} = 25^{\circ}C^{(e)}$	PD	26.3	W
Linear derating factor		213	mW/°C
Operating and storage temperature range	T <sub>j</sub> , T <sub>stg</sub>	-55 to 150	°C

#### **Thermal resistance**

Parameter	Symbol	Limit	Unit
Junction to ambient <sup>(a)</sup>	R <sub>OJA</sub>	117	°C/W
Junction to ambient <sup>(b)</sup>	R <sub>OJA</sub>	68	°C/W
Junction to ambient <sup>(c)</sup>	R <sub>OJA</sub>	51	°C/W
Junction to ambient <sup>(d)</sup>	R <sub>OJA</sub>	28	°C/W
Junction to case <sup>(e)</sup>	$R_{\Theta JC}$	4.5	°C/W

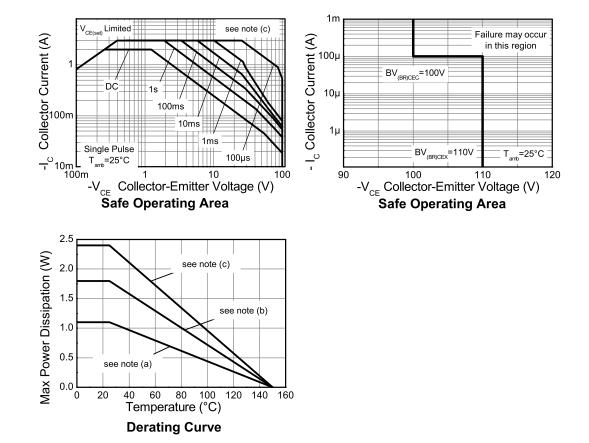
#### NOTES:

(a) For a device surface mounted on 15mm x 15mm x 0.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

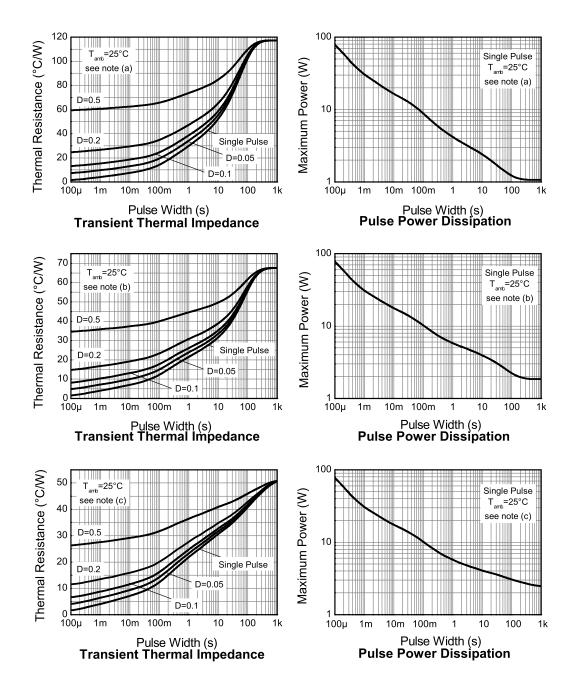
(b) Mounted on 25mm x 25mm x 0.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

(c) Mounted on 50mm x 50mm x 0.6mm FR4 PCB with high coverage of single sided 2oz copper, in still air conditions. (d) As (c) above measured at t<5 seconds.

(e) Junction to case (collector tab). Typical



#### **Thermal characteristics**



#### **Thermal characteristics**

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Collector-Base breakdown voltage	BV <sub>CBO</sub>	-110	-135		V	I <sub>C</sub> = -100μA
Collector-Emitter breakdown voltage	BV <sub>CEX</sub>	-110	-135		V	$I_E$ = -100μA, $R_{BC}$ < 1kΩ or 0.25V > $V_{BC}$ > -0.25V
Collector-Emitter breakdown voltage	BV <sub>CEO</sub>	-100	-130		V	I <sub>C</sub> = -10mA <sup>(*)</sup>
Emitter-Collector breakdown voltage (reverse blocking)	BV <sub>ECX</sub>	-7	-8.3		V	$I_E = -100$ μA, $R_{BC} < 1$ kΩ or 0.25V > V <sub>BC</sub> > -0.25V
Emitter-Collector breakdown voltage (reverse blocking)	BV <sub>ECO</sub>	-7	-8.7		V	I <sub>E</sub> = -100μA
Emitter-Base breakdown voltage	BV <sub>EBO</sub>	-7	-8.3		V	I <sub>E</sub> = -100μA
Collector-Base cut-off	I <sub>CBO</sub>		<1	-50	nA	V <sub>CB</sub> = -110V
current				-0.5	μA	$V_{CB} = -110V, T_{amb} = 100^{\circ}C$
Emitter cut-off current	I <sub>EBO</sub>		<1	-50	nA	V <sub>EB</sub> = -5.6V
Collector-Emitter	V <sub>CE(sat)</sub>		-100	-130	mV	I <sub>C</sub> = -0.5A, I <sub>B</sub> = -20mA <sup>(*)</sup>
saturation voltage			-100	-125	mV	$I_{C} = -1A$ , $I_{B} = -100mA^{(*)}$
			-180	-230	mV	$I_{C} = -1A, I_{B} = -50mA^{(*)}$
			-220	-295	mV	$I_{C} = -2A$ , $I_{B} = -200 \text{mA}^{(*)}$
Base-Emitter saturation voltage	V <sub>BE(sat)</sub>		-890	-1000	mV	$I_{C} = -2A, I_{B} = -200 \text{mA}^{(*)}$
Base-Emitter turn-on voltage	V <sub>BE(on)</sub>		-840	-950	mV	$I_{C} = -2A, V_{CE} = -2V^{(*)}$
Static forward current transfer ratio	h <sub>FE</sub>	200	300	500		$I_{C} = -100 \text{mA}, V_{CE} = -2V^{(*)}$
		70	130			$I_{C} = -1A, V_{CE} = -2V^{(*)}$
		20	25			$I_{C} = -2A, V_{CE} = -2V^{(*)}$
Transition frequency	f <sub>T</sub>		142		MHz	I <sub>C</sub> = -100mA, V <sub>CE</sub> = -10V f = 50MHz
Input capacitance	C <sub>ibo</sub>		291	400	pF	V <sub>EB</sub> = -0.5V, f = 1MHz <sup>(*)</sup>
Output capacitance	C <sub>obo</sub>		23.5	40	pF	V <sub>CB</sub> = -10V, f = 1MHz <sup>(*)</sup>
Delay time	t <sub>d</sub>		24.7		ns	
Rise time	t <sub>r</sub>		22.4		ns	I <sub>C</sub> = -500mA, V <sub>CC</sub> = -10V,
Storage time	t <sub>s</sub>		660		ns	$I_{B1} = -I_{B2} = -50 \text{mA}$
Fall time	t <sub>f</sub>		107		ns	R <sub>b</sub> =100Ω, R <sub>c</sub> =20Ω

### Electrical characteristics (at $T_{amb} = 25^{\circ}C$ unless otherwise stated)

#### NOTES:

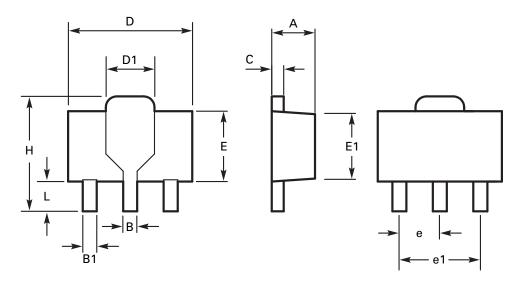
(\*) Measured under pulsed conditions. Pulse width  $\leq$  300µs; duty cycle  $\leq$  2%.



#### 0.4 I<sub>C</sub>/I<sub>B</sub>=10 Tamb=25°C I<sub>C</sub>/I<sub>B</sub>=50 0.3 - V<sub>CE(SAT)</sub> (V) 150°C I<sub>C</sub>/I<sub>B</sub>=20 100°C 25°C $I_{c}/I_{B} = 10$ 10m └─ 1m -55°C 0.0 10m $\begin{array}{c} 10m & 100m & 1 \\ -I_{c} & Collector Current (A) \\ V_{CE(SAT)} \lor I_{c} \end{array}$ - I<sub>c</sub> Collector Current (A) V<sub>CE(SAT)</sub> V I<sub>c</sub> 10 1.0 600 V<sub>CE</sub>=2V I\_/I\_=10 -55°C 1.6 150°C 500 1.4 Typical Gain (hFE) 0.8 Normalised Gain 1.2 () - V<sup>BE(SAT)</sup> - 0.4 100°C 1.0 0.8 150°C 25°C 0.6 100°C 25°C 0.4 -55°C 100 0.2 0.0 └─ 1m 0.2 L 1m 0 $\frac{10m}{l_{c}} \frac{100m}{c} \frac{1}{c}$ $\frac{10m}{l_{c}} \frac{1}{c}$ $\frac{10m}{l_{c}} \frac{1}{c}$ $\frac{10m}{l_{c}} \frac{1}{c}$ <sup>10m</sup> <sup>100m</sup> <sup>1</sup> - I<sub>c</sub> Collector Current (A) $\mathbf{h}_{_{\mathrm{FE}}} \mathbf{v} \mathbf{I}_{_{\mathrm{C}}}$ 1.2 400 V<sub>CE</sub>=2V 350 f = 1MHz 1.0 -55°C 300 Capacitance (pF) 25°C 250 - $V_{BE(ON)}$ (V) 0.8 Cibo 200 0.6 150 150°C 100 0.4 50 Cobo 100°C 0.2 **L** 1m 0 L 10m $\frac{10m}{V_{BE(ON)}} \frac{100m}{V_{C}} \frac{1}{C}$ 100m 1 - Voltage(V) 10 100 Capacitance v Voltage

### **Typical characteristics**

### Package outline - SOT89



DIM	Millin	neters	Inc	hes	DIM	Millimeters		Inches	
	Min	Мах	Min	Мах		Min	Мах	Min	Max
А	1.40	1.60	0.550	0.630	E	2.29	2.60	0.090	0.102
В	0.44	0.56	0.017	0.022	E1	2.13	2.29	0.084	0.090
B1	0.36	0.48	0.014	0.019	е	1.50	BSC	0.059	BSC
С	0.35	0.44	0.014	0.017	e1	3.00	BSC	0.118	BSC
D	4.40	4.60	0.173	0.181	Н	3.94	4.25	0.155	0.167
D1	1.52	1.83	0.064	0.072	L	0.89	1.20	0.035	0.047

Note: Controlling dimensions are in millimeters. Approximate dimensions are provided in inches

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